Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	er
10/537,830	HIRAI, HIDEAKI	
Examiner	Art Unit	
TAN Y DINH	2627	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	ce Search Printout	1/2/2008	T.D

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST (see search history printout)	1/2/2008	T.D
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